

Maximum Ratings

Parameter	Symbol	Value	Unit	
Collector-emitter voltage	V _{CEO}		V	
BCX51		45		
BCX52		60		
BCX53		80		
Collector-base voltage	V _{CBO}			
BCX51		45		
BCX52		60		
BCX53		100		
Emitter-base voltage	V _{EBO}	5		
Collector current	I _C	1	A	
Peak collector current, $t_p \le 10 \text{ ms}$	I _{CM}	1.5		
Base current	I _B	100	mA	
Peak base current	/ _{BM}	200		
Total power dissipation	P _{tot}	2	W	
<i>T</i> _S ≤ 120 °C				
Junction temperature	Tj	150	°C	
Storage temperature	T _{stg}	-65 150		
Thermal Resistance				
Parameter	Symbol	Value	Unit	
Junction - soldering point ¹⁾	R _{thJS}	≤ 15	K/W	

¹For calculation of R_{thJA} please refer to Application Note AN077 (Thermal Resistance Calculation)



Electrical Characteristics at $T_A = 25^{\circ}C$, unless Parameter	Symbol	Values			Unit
		min.	typ.	max.]
DC Characteristics	1			1	1
Collector-emitter breakdown voltage	V _{(BR)CEO}				V
<i>I</i> _C = 10 mA, <i>I</i> _B = 0 , BCX51		45	-	-	
$I_{\rm C}$ = 10 mA, $I_{\rm B}$ = 0 , BCX52		60	-	-	
$I_{\rm C}$ = 10 mA, $I_{\rm B}$ = 0 , BCX53		80	-	-	
Collector-base breakdown voltage	V _{(BR)CBO}				
/ _C = 100 μA, / _E = 0 , BCX51		45	-	-	
$I_{\rm C}$ = 100 µA, $I_{\rm E}$ = 0 , BCX52		60	-	-	
$I_{\rm C}$ = 100 µA, $I_{\rm E}$ = 0 , BCX53		100	-	-	
Emitter-base breakdown voltage	V _{(BR)EBO}	5	-	-	1
<i>I</i> _E = 10 μA, <i>I</i> _C = 0					
Collector-base cutoff current	I _{CBO}				μA
$V_{\rm CB} = 30 \text{ V}, I_{\rm E} = 0$		-	-	0.1	
$V_{\rm CB}$ = 30 V, $I_{\rm E}$ = 0 , $T_{\rm A}$ = 150 °C		-	-	20	
DC current gain ¹⁾	h _{FE}				-
$I_{\rm C}$ = 5 mA, $V_{\rm CE}$ = 2 V		25	-	-	
<i>I</i> _C = 150 mA, <i>V</i> _{CE} = 2 V, BCX51BCX53		40	-	250	
<i>I</i> _C = 150 mA, <i>V</i> _{CE} = 2 V, BCX53-10		63	100	160	
$I_{\rm C}$ = 150 mA, $V_{\rm CE}$ = 2 V, BCX51-16BCX53-16		100	160	250	
$I_{\rm C}$ = 500 mA, $V_{\rm CE}$ = 2 V		25	-	-	
Collector-emitter saturation voltage1)	V _{CEsat}	_	-	0.5	V
I _C = 500 mA, I _B = 50 mA					
Base-emitter voltage ¹⁾	V _{BE(ON)}	-	-	1	1
I _C = 500 mA, V _{CE} = 2 V	()				
AC Characteristics					-
Transition frequency	f _T	-	125	-	MHz
<i>I</i> _C = 50 mA, <i>V</i> _{CE} = 10 V, <i>f</i> = 20 MHz					
		L	I	1	

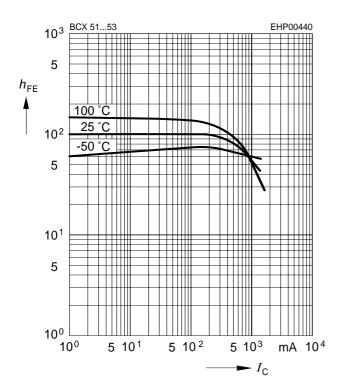
Electrical Characteristics at $T_A = 25^{\circ}$ C, unless otherwise specified

¹Pulse test: t < 300 μ s; D < 2%

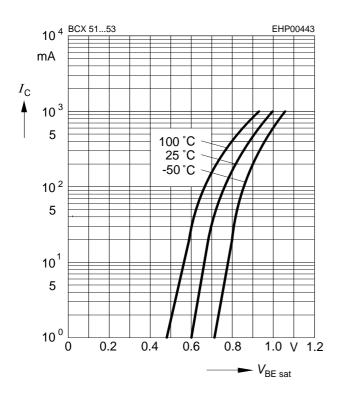


DC current gain $h_{\text{FE}} = f(I_{\text{C}})$

 V_{CE} = 2 V

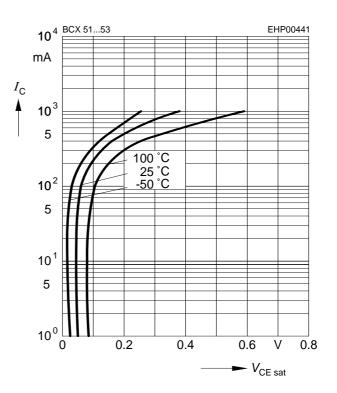


Base-emitter saturation voltage $I_{\rm C} = f(V_{\rm BEsat}), h_{\rm FE} = 10$

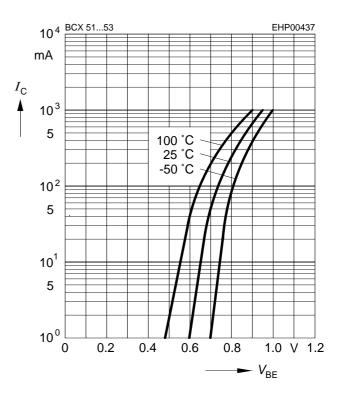


Collector-emitter saturation voltage

 $I_{\rm C} = f(V_{\rm CEsat}), h_{\rm FE} = 10$



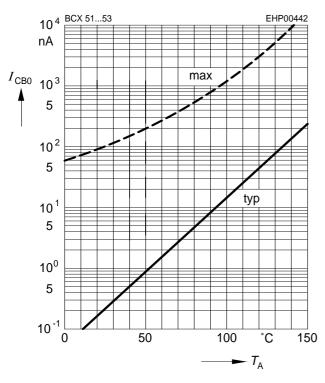
Collector current $I_{\rm C} = f(V_{\rm BE})$ $V_{\rm CE} = 2V$





Collector cutoff current $I_{CBO} = f(T_A)$

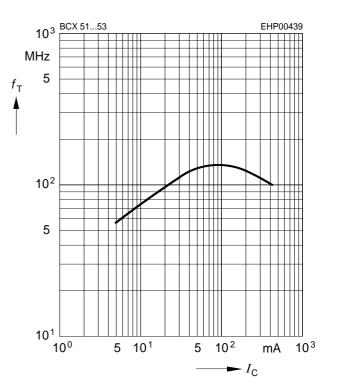
 $V_{\rm CBO}$ = 30 V



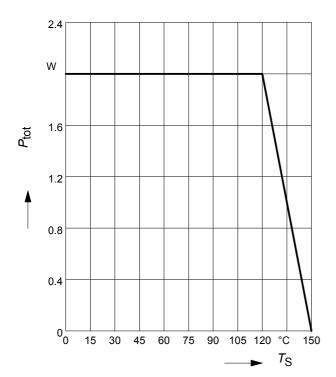
Total power dissipation $P_{tot} = f(T_S)$

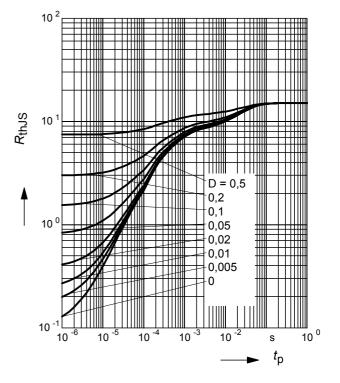


*V*_{CE} = 10 V



Permissible Pulse Load $R_{\text{thJS}} = f(t_p)$

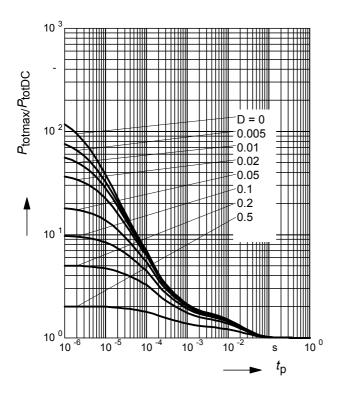




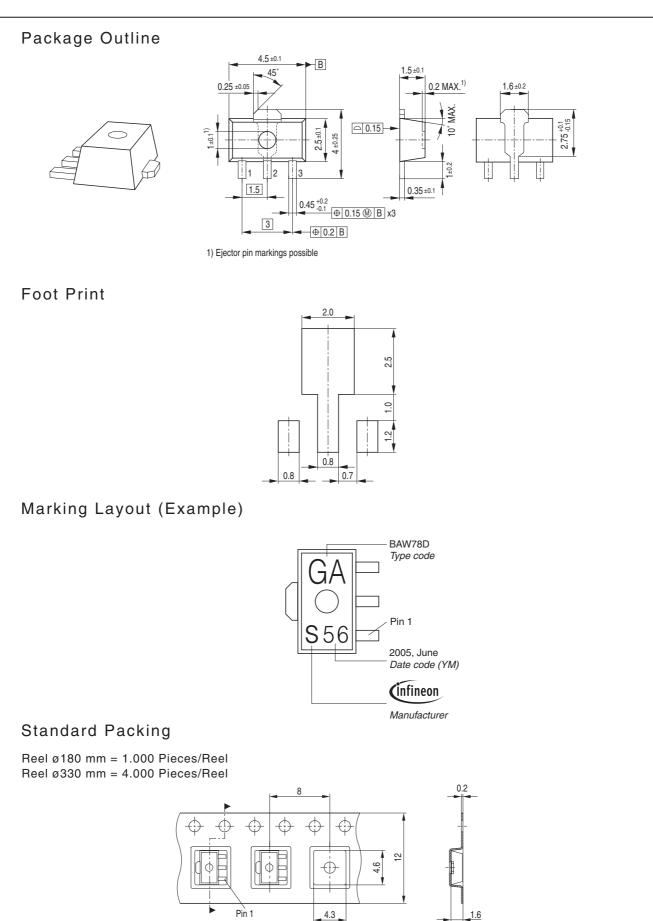


Permissible Pulse Load

 $P_{\text{totmax}}/P_{\text{totDC}} = f(t_{p})$









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